

NIKHEF activities within EUDET/SITPC

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Overview

- (motivations)
- An integrated Micromegas
 - Study of geometry, gain & resolution
- A protection against gas discharges
 - A high resistive layer as spark quencher
 - Recording discharge signals...
- A double stage integrated detector
 - Between GEM and Micromegas...

Pixel readout of gaseous detector

Electronic channels $\times 10^3$

Data rate \sim Gbits/s !

Endplate: chip tiling, dead areas

High granularity (pixel size)

Single electron sensitivity

Cluster counting (?)

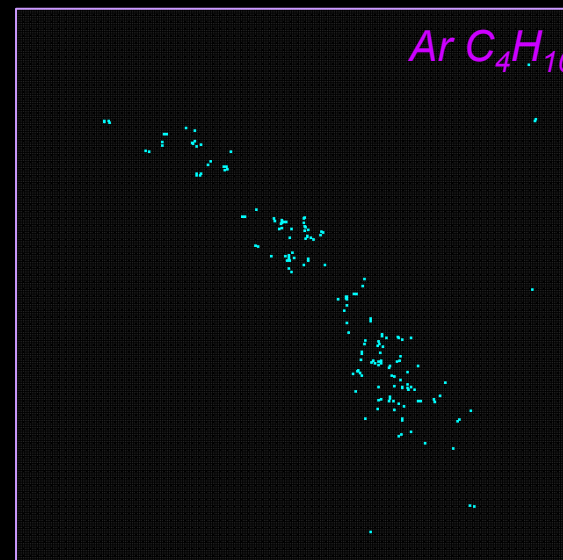
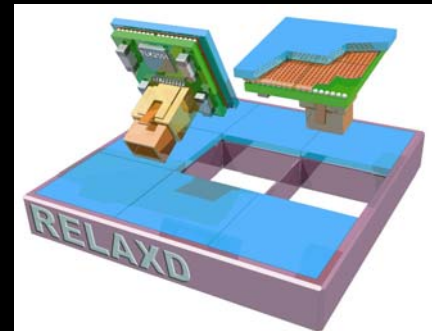
Low input capacity (~ 50 fF)

Low gain operation

Reduced discharge risk

Reduced ion backflow

δ -rays suppression



He C₄H₁₀



InGrid, an integrated Micromegas

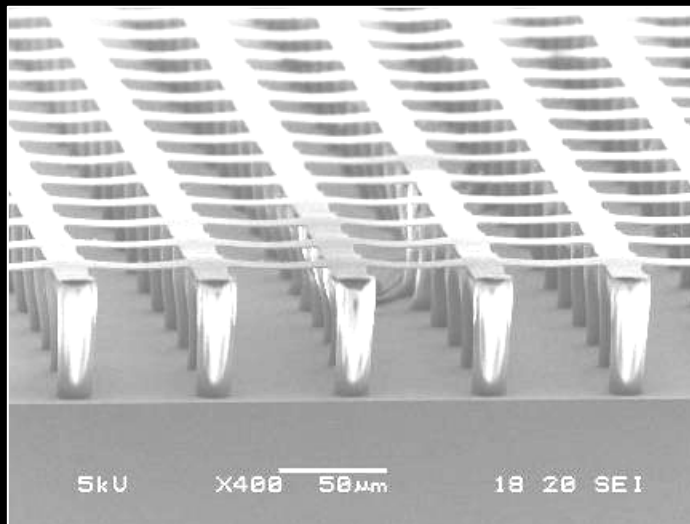
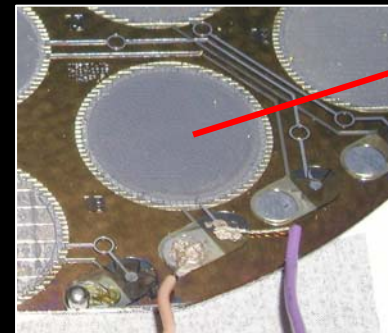
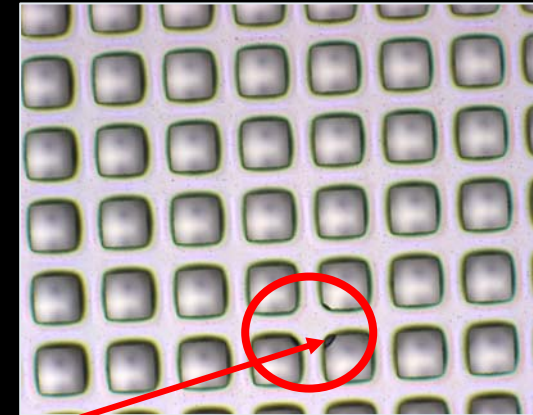
- **Integrate grid by wafer post processing**

Low temperature process (spin coating, wet etching)

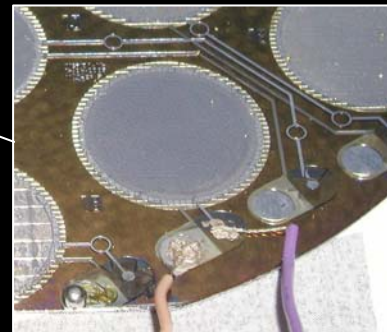
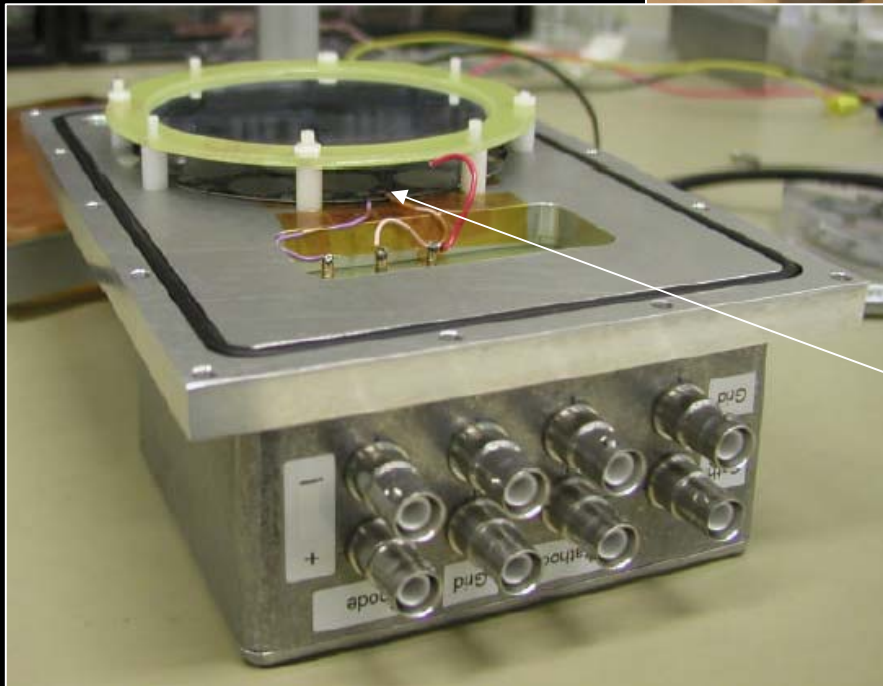
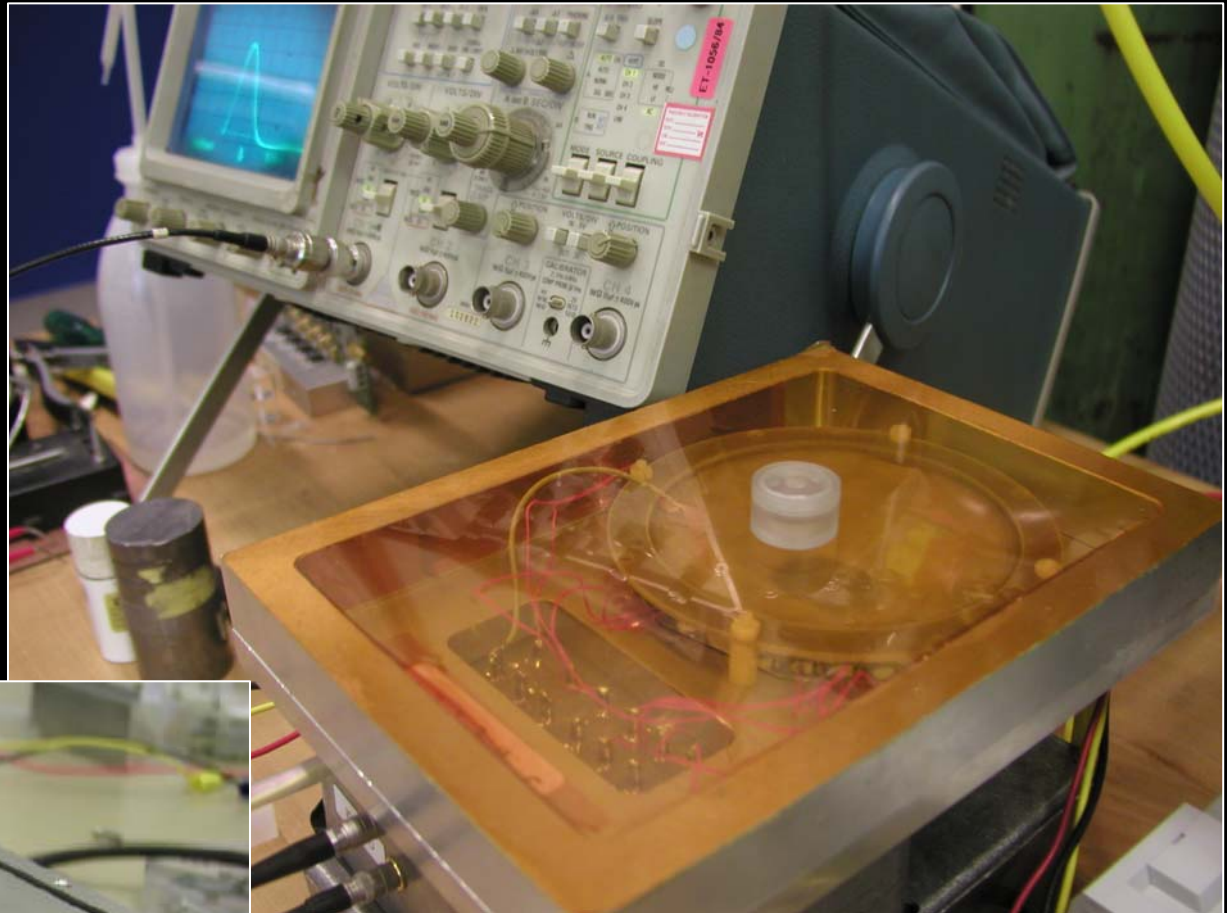
Perfect alignment between grid holes and pixel pads

No dead areas due to pillars

Flexible design

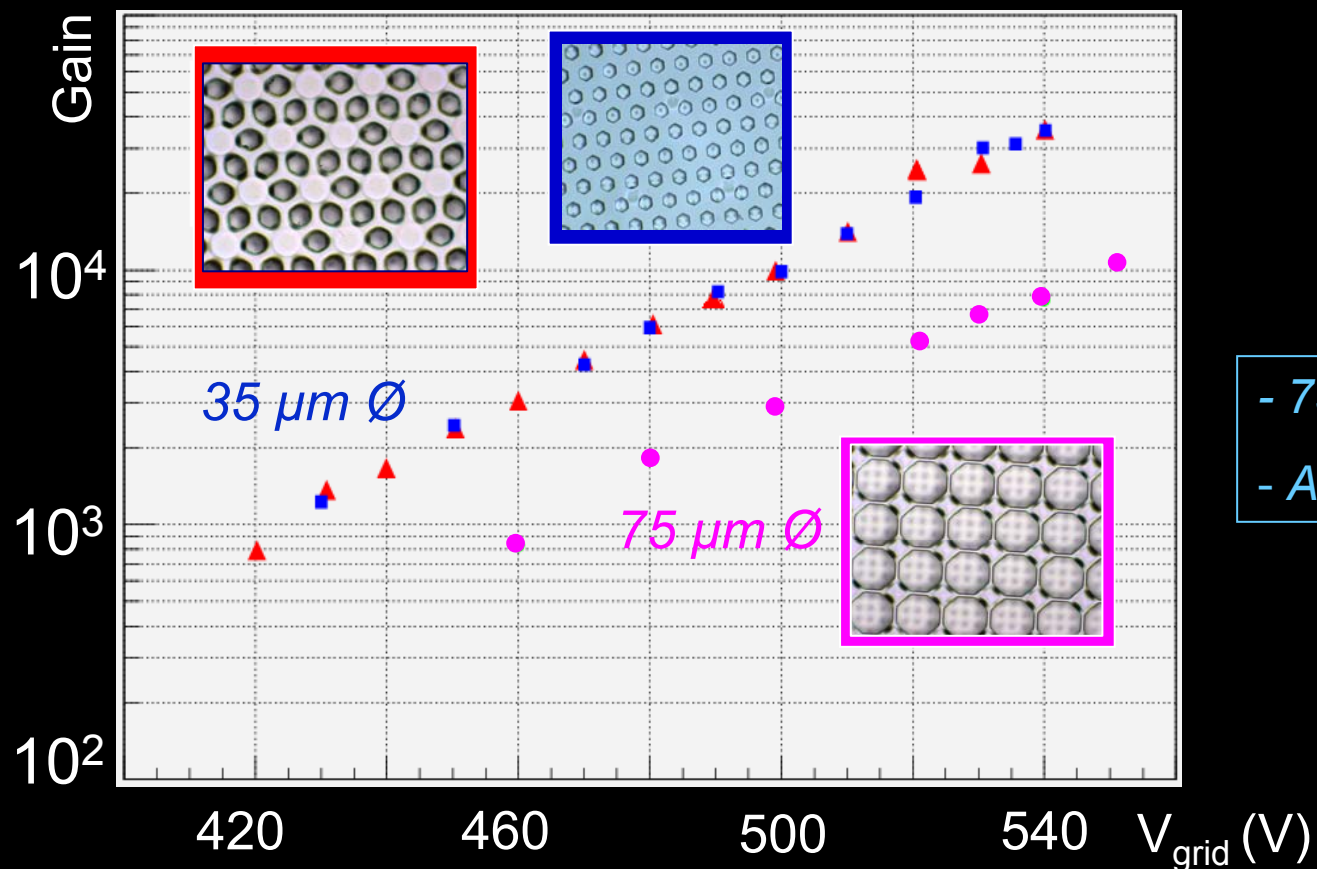


Experimental setup



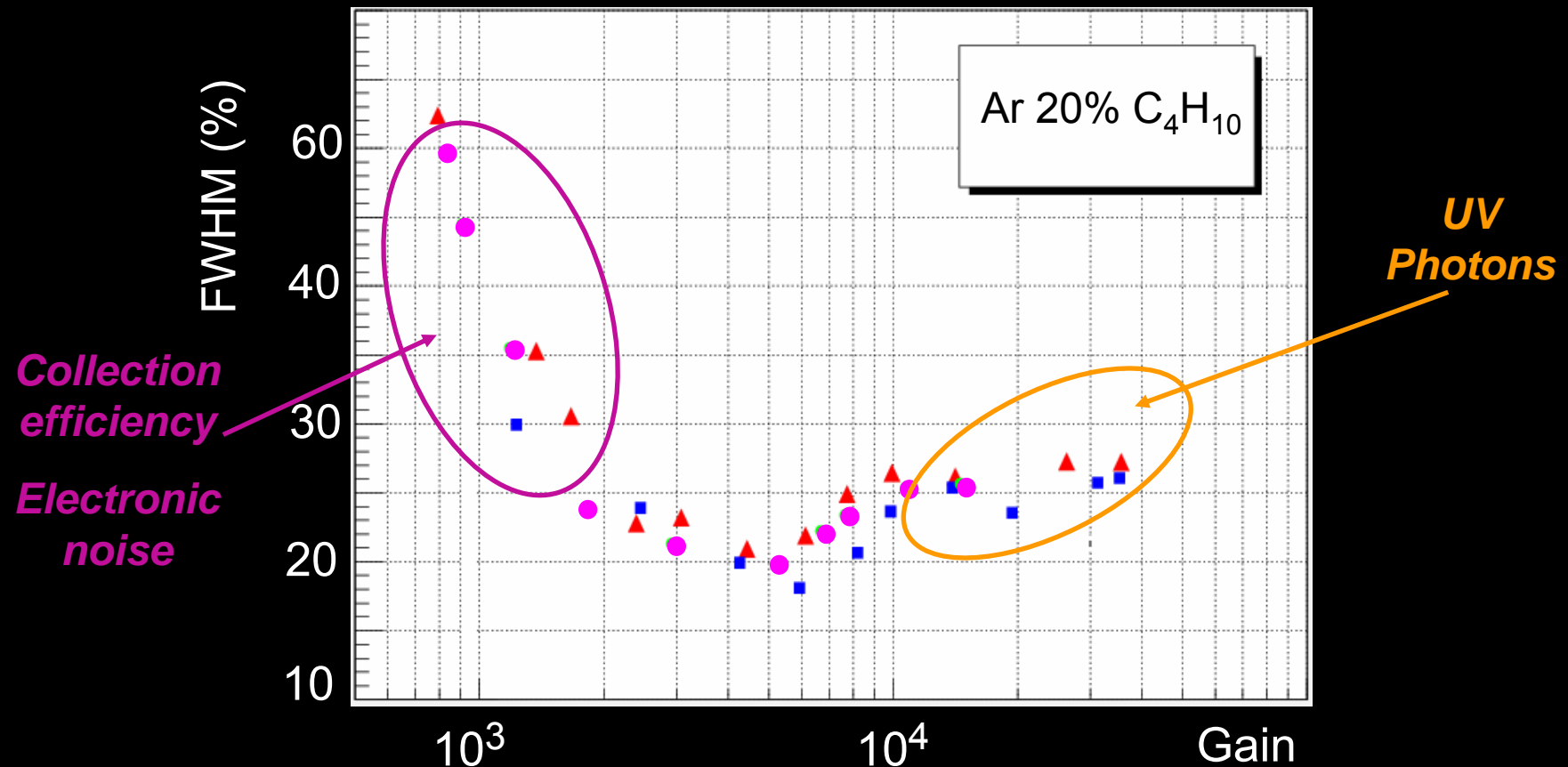
Grid geometry study (I)

- Gain larger for smaller holes
- Gain slope independant of grid geometry
- Gain maximum @ 75 μm de gap $\sim 4 \cdot 10^4$



Grid geometry study (II)

- Resolution minimum @ $G \sim 5 \cdot 10^3$
- Resolution almost independant of grid geometry
- Resolution record for 50 μm gap InGrid of 13 % FWHM



Gain and gap theory

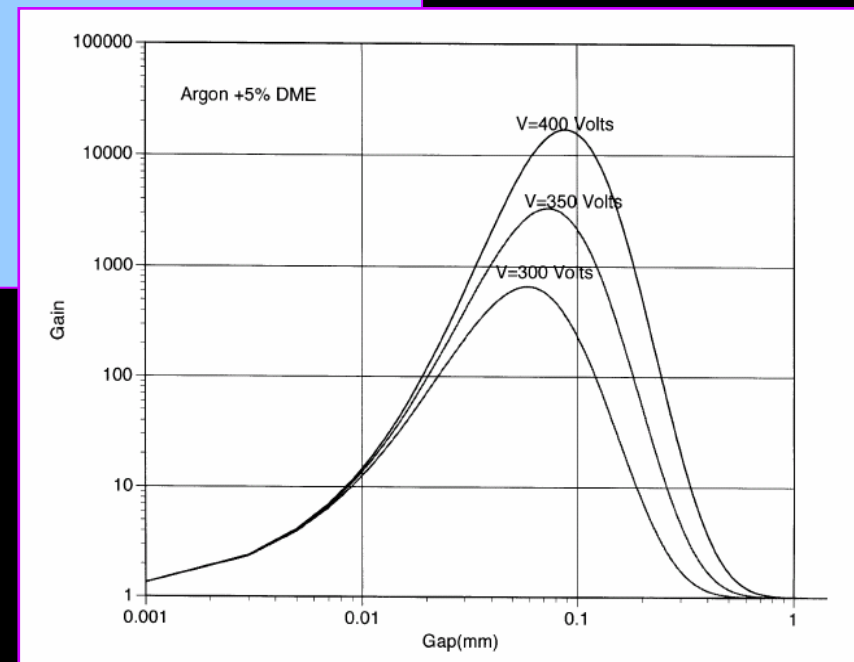
$$\text{Gain} = e^{N_{ion}} = e^{\alpha d} = e^{\alpha g}$$

$$\alpha = A P e^{-BP / E}$$

Rose and Korf formula

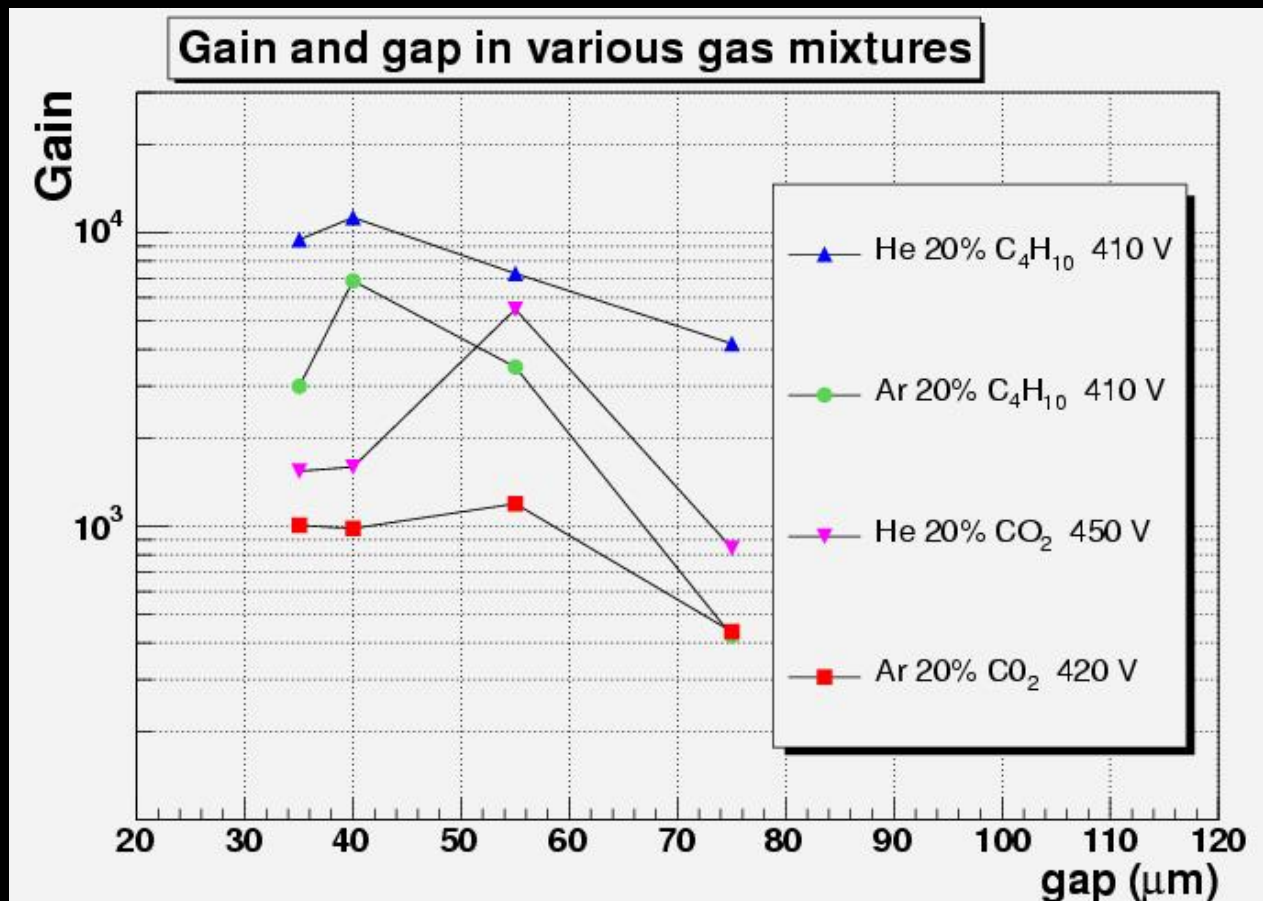
$$\text{Gain} = e^{g A P e^{-BP / E}}$$

Maximum predicted for a given gas and grid voltage



Gain and gap study

- Gas used: Ar / He / C₄H₁₀ / CO₂
- Prototypes: 35, 40, 55, 75 μm InGrids

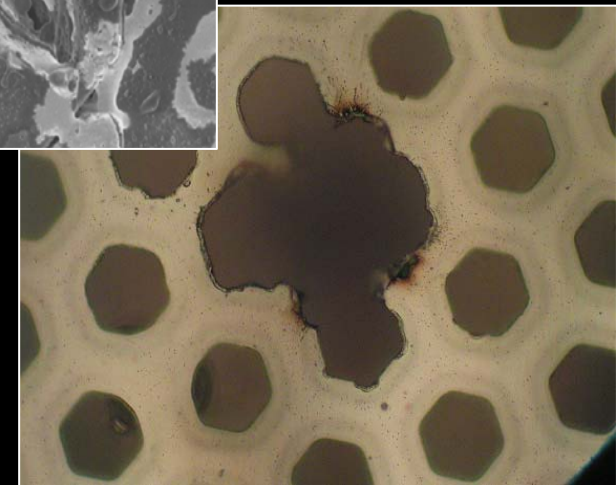
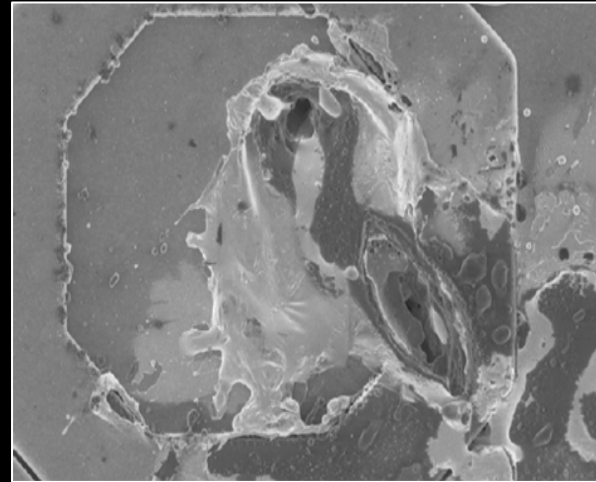


More gap thicknesses required

Optimum gap between 40 μm and 55 μm

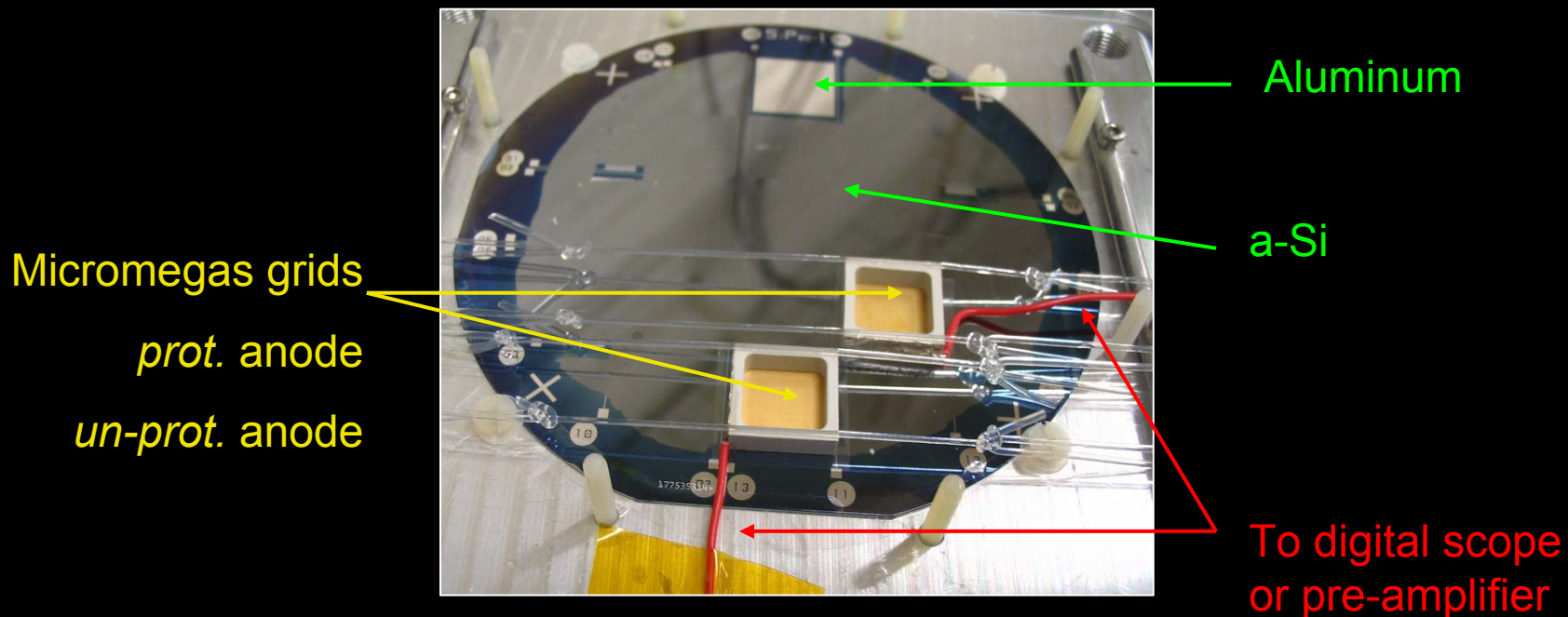
Gas discharge protection

- Melt pixel pad
- Grid damaged
 - 1 μm thin grid
 - Aluminum $T_f \sim 660 \text{ }^\circ\text{C}$
- **Proposals:**
 - Resistive layer, RPC principle
 - **SiProt**
 - Multi-stage amplification
 - **TwinGrid**



The SiProt chamber

- Low temperature deposition ($< 250^{\circ}\text{C}$) of a $4\ \mu\text{m}$ thick a-Si layer of $10^{11}\ \Omega\cdot\text{cm}$ resistivity
- Experimental setup:
 - 1 bare anode and 1 a-Si covered anode with Micromegas on top
 - Gain curve with an Iron 55 source
 - Induce discharges by means of 5 MeV alphas
 - Record grid signals

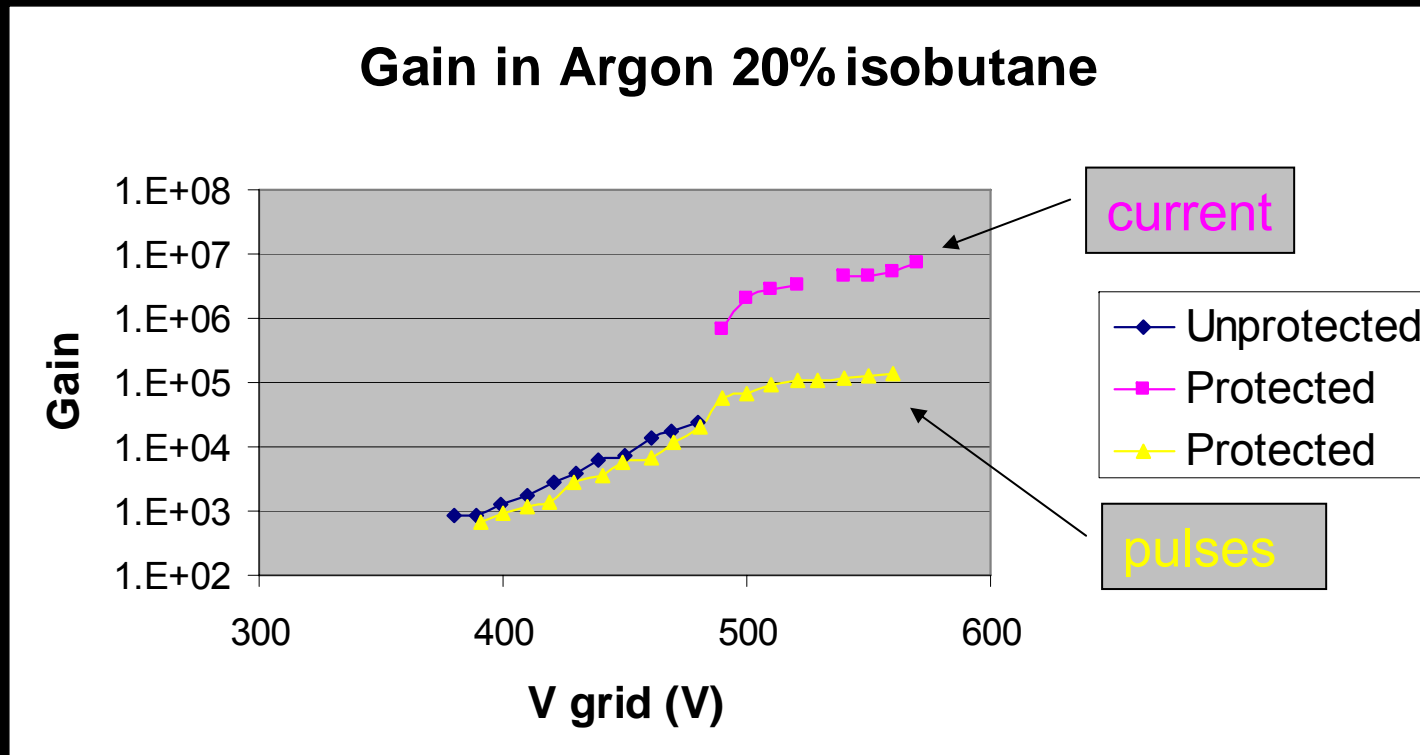


Iron 55 source

Gain

Look at the pulses from a pre amplifier (low grid voltage)

Look at the current flowing through the power supply (high grid voltage)

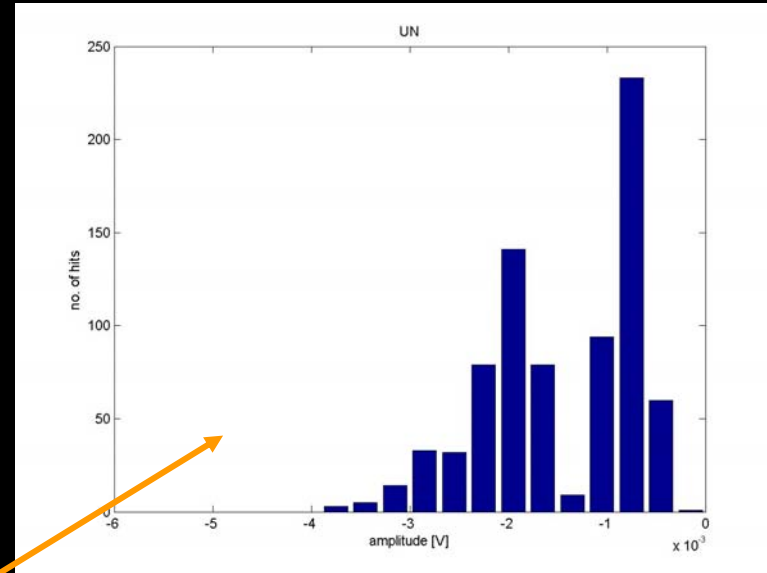


No sparks up to 570 V on the grid !

Burn the grid above 570...

Signals study

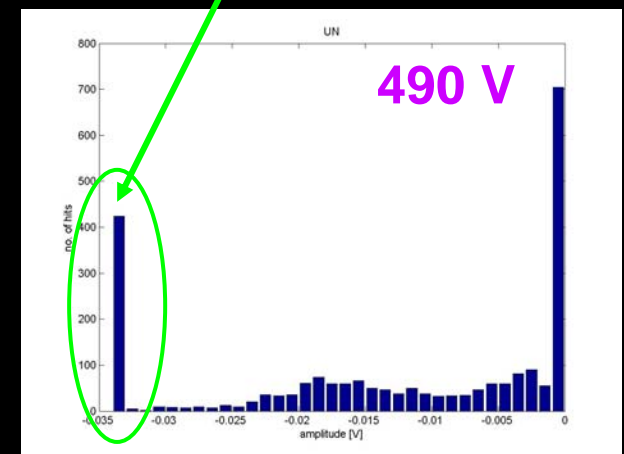
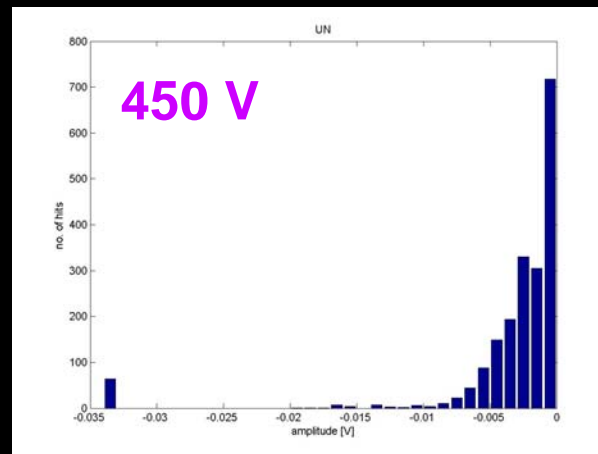
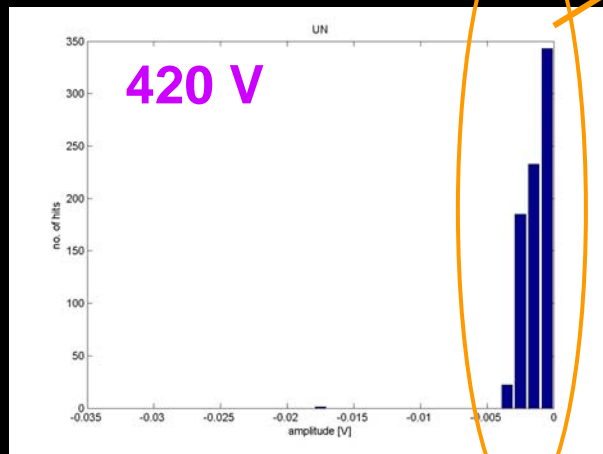
- No pre amplifier
- Ar 20 % C₄H₁₀
- Signals from ~ 5 MeV alphas
- Fast digital scope

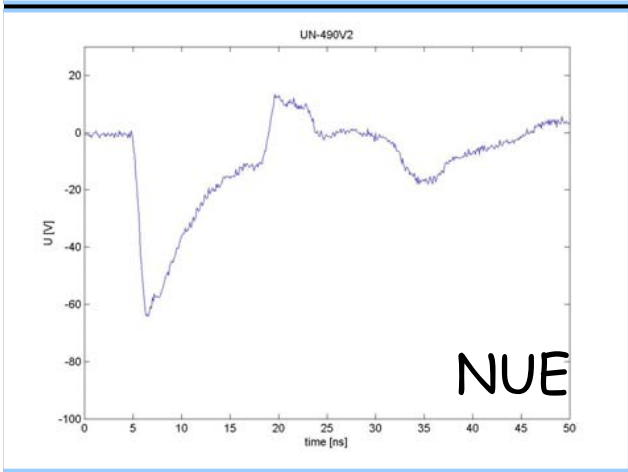
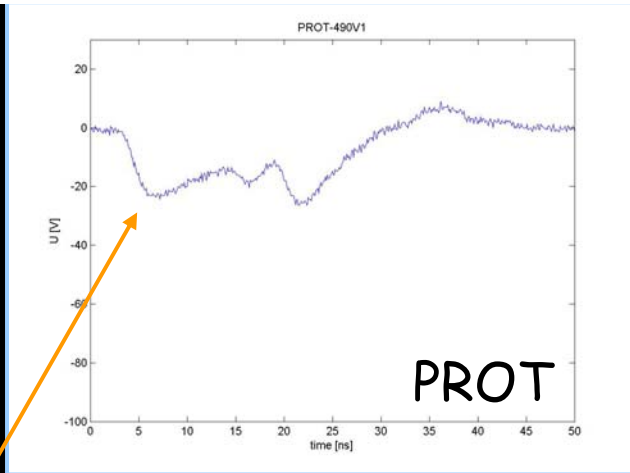
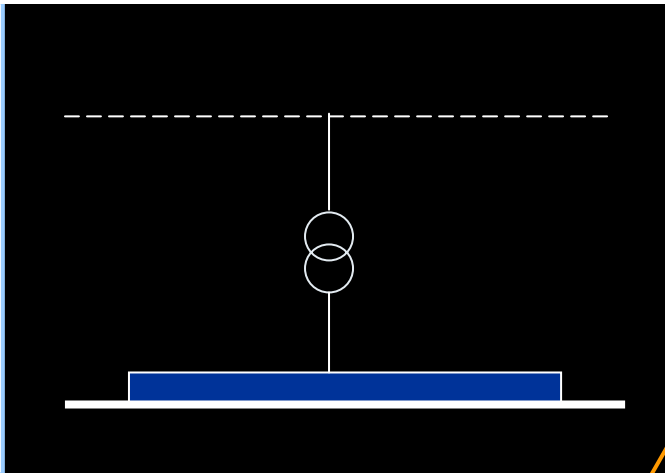
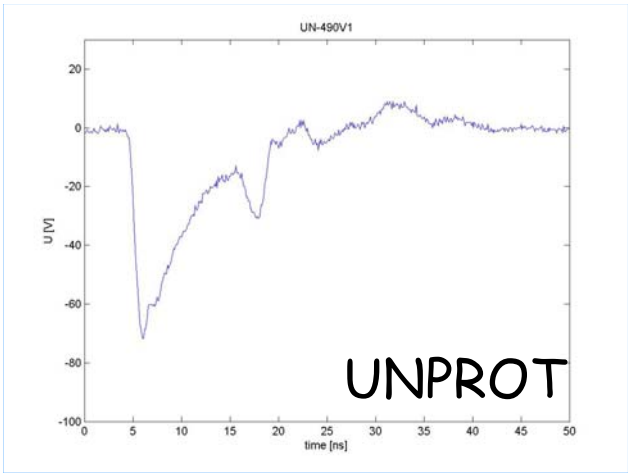


proportionals

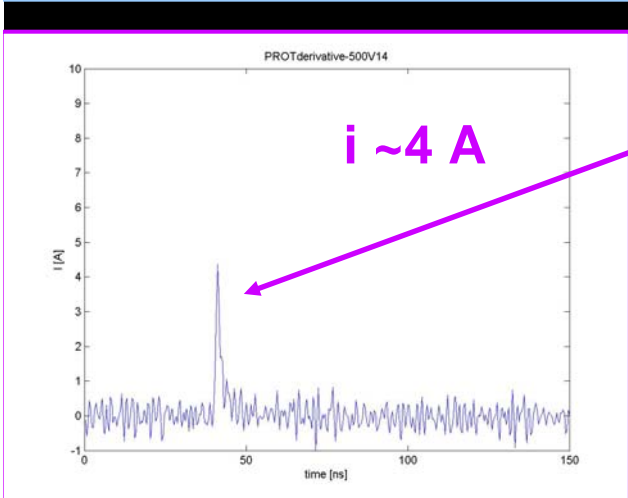
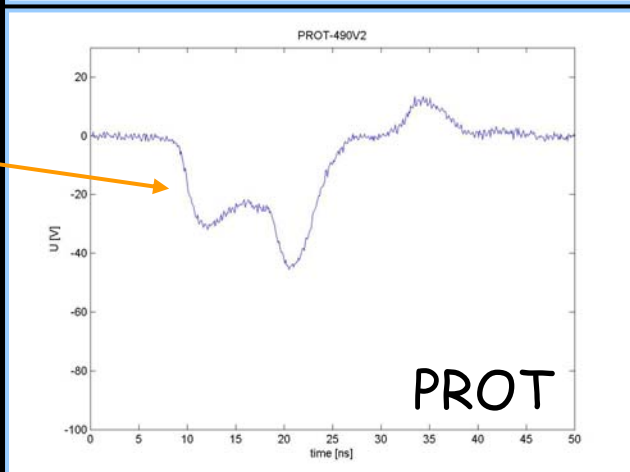
discharges

Charge spectra



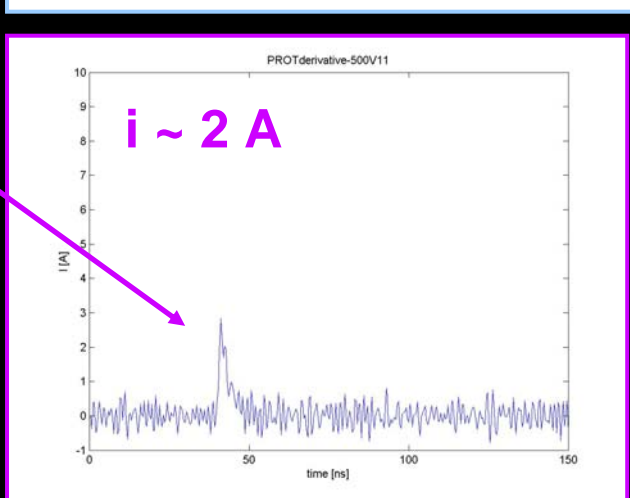


Slope less steep for protected anode



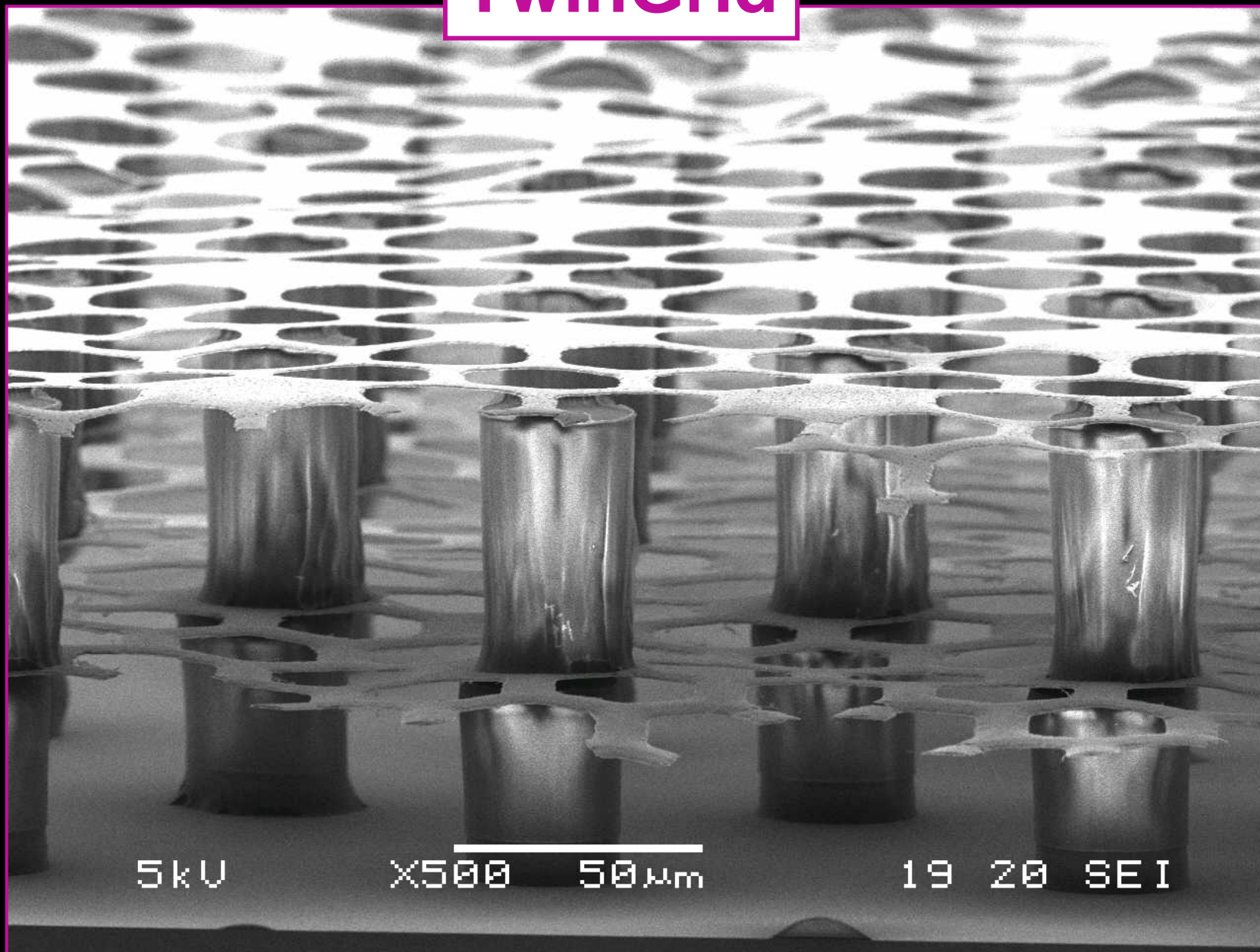
Current reduced

Enough to protect the chip?



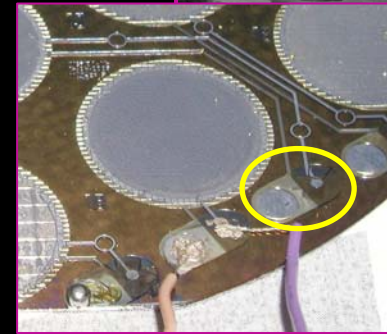
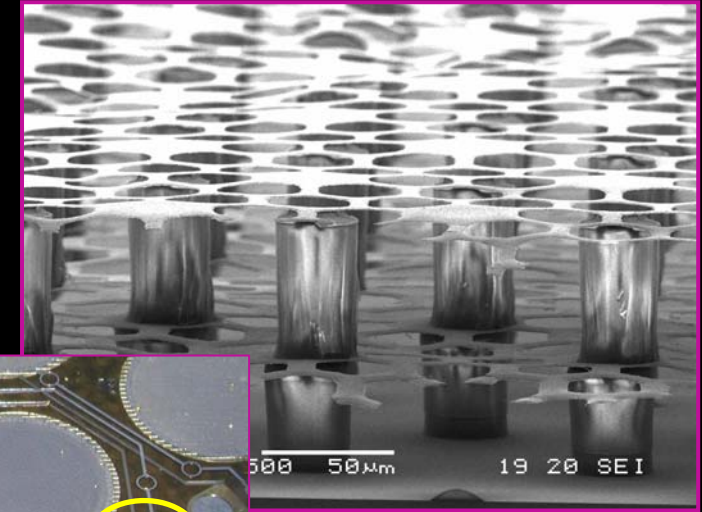
If SiProt is not enough ...

TwinGrid

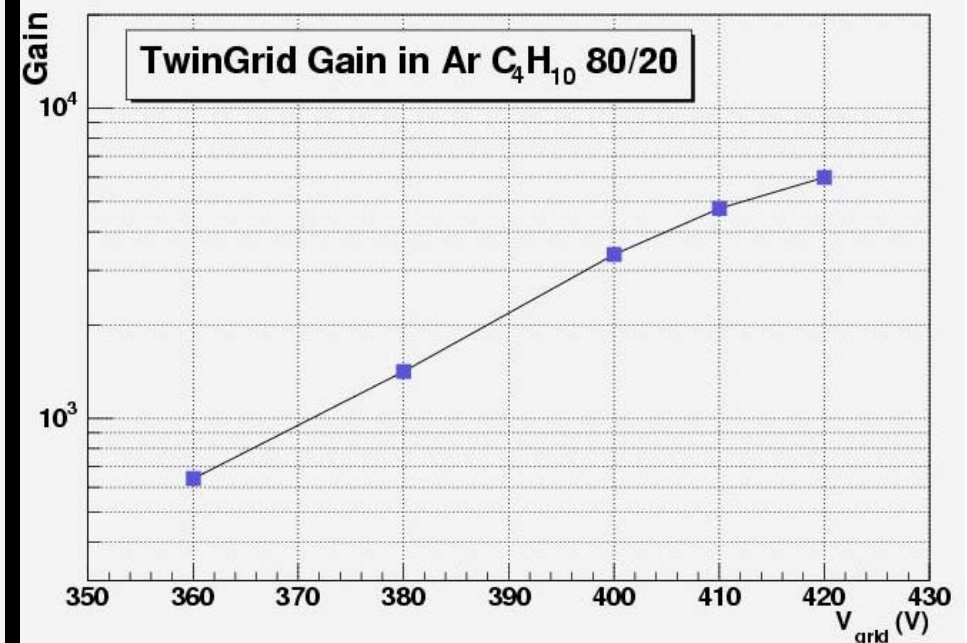
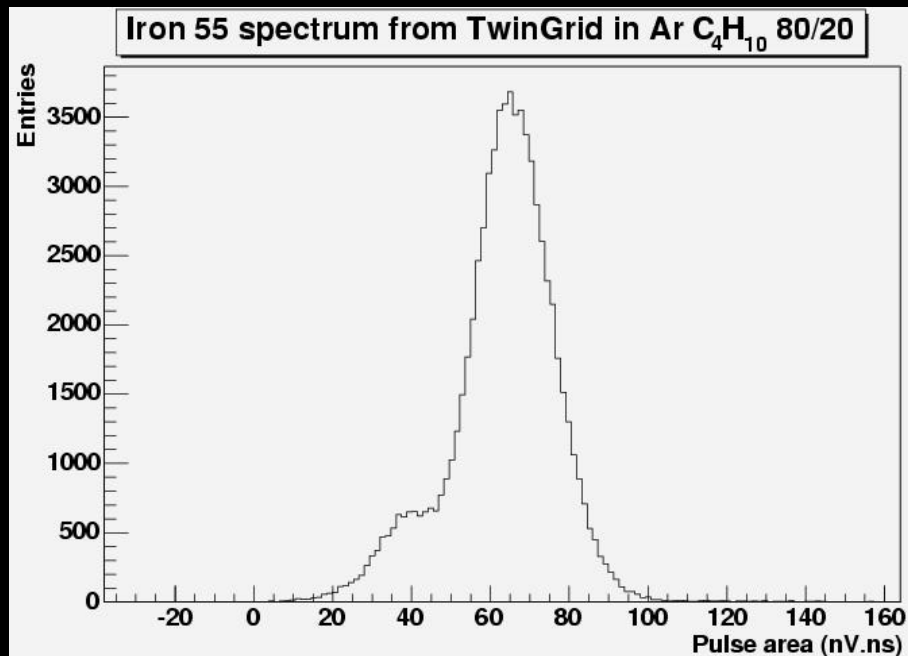


And it works!

- Ar 20 % C₄H₁₀, Iron 55 source
- Voltage on top grid, middle grid floating
- Signal development? Field shape?
- Readout grid signals

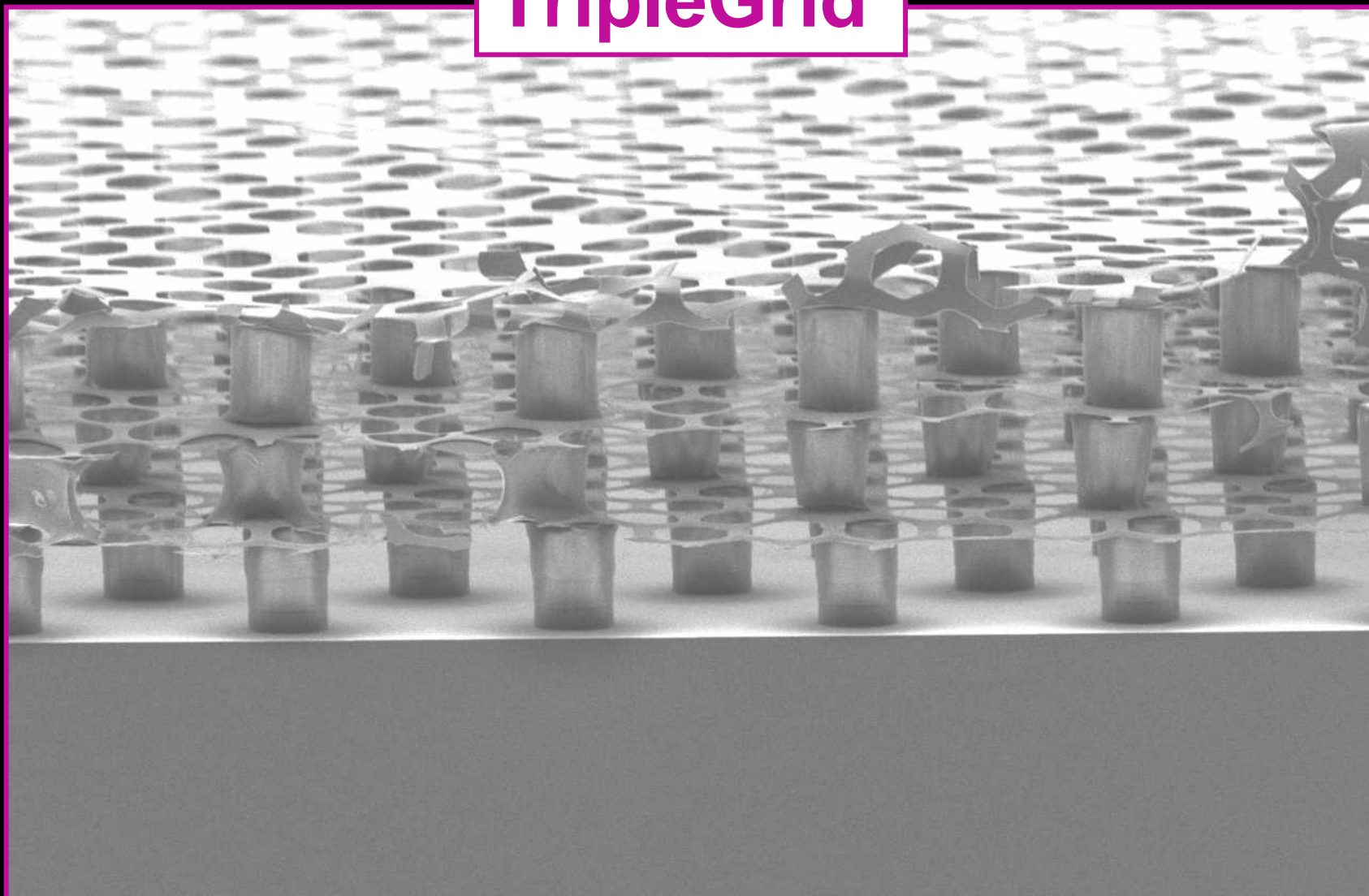


2 grid lines on top of each other



If TwinGrid is not enough ...

TripleGrid



5kV

X230 100µm

17 18 SEI

Acknowledgments

NIKHEF

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